



Subject card

Subject name and code	Microscopic Methods in Nanotechnology, PG_00069347						
Field of study	Nanotechnology						
Date of commencement of studies	October 2025	Academic year of realisation of subject				2026/2027	
Education level	first-cycle studies	Subject group					
Mode of study	Full-time studies	Mode of delivery				at the university	
Year of study	2	Language of instruction				Polish	
Semester of study	4	ECTS credits				1.0	
Learning profile	general academic profile	Assessment form				assessment	
Conducting unit	Institute of Nanotechnology and Materials Engineering -> Faculty of Applied Physics and Mathematics -> Faculties of Gdańsk University of Technology						
Name and surname of lecturer (lecturers)	Subject supervisor		dr hab. inż. Jakub Karczewski				
	Teachers		dr hab. inż. Jakub Karczewski				
Lesson types	Lesson type	Lecture	Tutorial	Laboratory	Project	Seminar	SUM
	Number of study hours	0.0	0.0	15.0	0.0	0.0	15
	E-learning hours included: 0.0						
Learning activity and number of study hours	Learning activity	Participation in didactic classes included in study plan		Participation in consultation hours		Self-study	SUM
	Number of study hours	15		1.0		9.0	25
Subject objectives	Understanding modern methods of imaging nanostructures.						
Learning outcomes	Course outcome		Subject outcome		Method of verification		
	[K6_U02] can analyze and solve simple scientific and technical problems based on possessed knowledge, applying analytical, numerical, simulation and experimental methods.		The student is able to prepare samples of nanomaterials for imaging using selected microscopic methods.		[SU3] Assessment of ability to use knowledge gained from the subject [SU4] Assessment of ability to use methods and tools		
	[K6_W09] Has knowledge of the structure and operation of scientific instruments, measuring and test equipment and in the field of planning and conducting a physical experiment and critical analysis of its results.		The student knows and understands the principles of operation and is able to perform measurements using SEM, AFM, and STM microscopy.		[SW1] Assessment of factual knowledge		
	[K6_U04] can plan and conduct experiments, critically analyze their results, draw conclusions and formulate opinions. Has laboratory experience.		The student is able to prepare, perform, and interpret an experiment using modern imaging methods.		[SU2] Assessment of ability to analyse information [SU3] Assessment of ability to use knowledge gained from the subject [SU4] Assessment of ability to use methods and tools		
Subject contents	Course content – laboratory Imaging of nanomaterials using tunneling microscopy, atomic force microscopy, and scanning electron microscopy						
Prerequisites and co-requisites	knowledge of basic physics						
Assessment methods and criteria	Subject passing criteria		Passing threshold		Percentage of the final grade		
	presentation of laboratory work results		50.0%		100.0%		
Recommended reading	Basic literature		<ul style="list-style-type: none"> <li>Weillie Zhou Zhong Lin Wang "Scanning Microscopy for Nanotechnology Techniques and Applications"</li> <li>V. L.Mironov"Fundamentals of Scanning Probe Microscopy"</li> </ul>				
	Supplementary literature		Nanosurf easyScan 2 - operating instruction				
	eResources addresses						

Example issues/ example questions/ tasks being completed	<ul style="list-style-type: none"><li>• Imaging gold nanoparticles using AFM</li><li>• Imaging carbon nanotubes using SEM</li></ul>
Practical activities within the subject	Not applicable

Document generated electronically. Does not require a seal or signature.